

Notice of References Cited

Application/Control No.

10/594,221

Applicant(s)/Patent Under

Reexamination

SUEYOSHI ET AL.

Examiner

ROBERT LOEWE

Art Unit

1766

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,307,081 B1	10-2001	Takiuchi et al.	556/434
B	US-			
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K	US-			
L	US-			
M	US-			

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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